## Photovoltaic Effects Exhibited in High-resistance Semi-conducting Films

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Semi-conducting Films MICROCRYSTALLINE layers of lead sulphide have been obtained which, after suitable activation, exhibit photovoltaic effects of a new type. The photosensitive layer consists of a film about 1 micron in thick-ness deposited on glass between graphite electrodes a few millimetres apart. When illuminated by infra-red radiation of wave-length between the electrodes. It has been shown that this effect is inde-pendent of the contacts between the semi-conductor and the electrodes, and is due to the internal properties of the sensitive material. Cells with resistance of a few megohms and photo E.M.F. is developed between produced. These cells, as might be expected, show pro-nounced rectifying properties, the ratio of conductivities for opposite directions of current being about 100: 1 at room temperature. The photo current is always in the direction of high resistance. The cells were produced as a result of information obtained during development work on the photoconductivity of activated thalium sulphide and lead sulphide layers. It is generally accepted that con-ductivity in semi-conductors is associated with the presence of in-purity centres in the crystalline lattice. The impurity centres may be either electro-positive or electro-negative, giving rise respectively to 'electronic' or hole' components of conductivity. Consideration of our results obtained from sensitizing treatments in oxygen and *in eacuo* leads to the conclusion that impurity centres of either sign may be introduced, and further support is given to this by measurements of the Hall coefficient. High conductivity consideration of our resistance is obtained, which may be explained by the existence of impurity of one sign alone is not associated with photosensitivity. The best photoconductivity in a given layer appears when maximum resistance of barriers at the boundaries of the crystals, with unequal of normal photoconductivity centres on opposite sides. The properties of new sismultiferent from

pronounced. Under certain conditions, non-uniform activation across the cell may be obtained ; and it is found that the photovoltaic and photo-conductive sensitivity are always associated with the same part of the layer, as would be expected from the above considerations. Also in exceptional cases the sensitive area can be displaced across the layer towards the positive electrode, indicating the mobility of negative centres and a fairly uniform distribution of positive centres. A full description of the experimental work and a more detailed development of the theoretical considerations will be given elsewhere. J. STARKIEWICZ L. SOSNOWSKI O. SIMPSON

Admiralty Research Laboratory, Teddington, Middlesex. May 25.

## Surface Area Determination

Is the determination of surface area using nitrogen at the tempera-ture of liquid nitrogen by the method of Brunauer, Emmett and Teller', it is usual to determine the dead-space on each sample, using helium. For routine determinations on a substance known to give S-shaped isotherms, that is, where the equation of Brunauer, Emmett and Teller is applicable, it is possible to avoid this dead-space determ-ination. If  $V_1$  c.c. nitrogen are adsorbed at a pressure  $p_1$ , then the dead-space is given by

$$p_1 (1 + \alpha)D \simeq p_1 D,$$

where D is dead-space at unit pressure and a is a correction factor equal to  $6.58 \times 10^{-5}$  at unit pressure. Hence, if  $V_{c_1}$  is volume of nitrogen in the sample bulb, then

 $V_1 = V_{c_1} - p_1 D; \ V_2 = V_{c_2} - p_2 D; \ V_3 = V_{c_3} - p_3 D.$ It follows that

$$V_1 = V_{c_1} - p_1 \left( \frac{V_{c_3} - V_3}{p_3} \right).$$

Emmett<sup>2</sup> points out that a line drawn through the origin and one adsorption point at a relative pressure of c. 0.3 usually differs in slope by less than 5 per cent from that drawn using several adsorption points.

$$V_1 (p_0 - p_1) = V_2 (p_3 - p_2) = V_3 (p_0 - p_3).$$
  
Therefore

$$V_1 = V_{c_1} - \frac{p_1}{p_3} \left( V_{c_3} - V_1 \cdot \frac{p_0 - p_1}{p_0 - p_3} \right).$$

Rearranging.

$$V_1 = rac{V_{c_1} - V_{c_3} rac{p_1}{p_3}}{1 - rac{p_1}{p_3} \left( rac{p_0 - p_1}{p_0 - p_2} 
ight)};$$

and similarly for  $V_2$ .

In the plot of  $p/p_0$  against  $\frac{p}{V(p_0-p)}$ , the monolayer volume  $V_m$  is the reciprocal of the slope, that is,

$$V_m = \frac{(p_2 - p_1)/p_0}{p_2 / \{ V_2(p_0 - p_2) \} - p_1 / \{ V_1(p_0 - p_1) \}}.$$
 (1)

This involves determining three adsorption points, but no dead-space : a slightly less accurate value can be found using only two points, that is,

$$V_m = \frac{p_1/p_0}{p_1/\{V_1(p_0 - p_1)\}} = \frac{V_1}{p_0}(p_0 - p_1).$$

In neither case is it necessary actually to plot the points. Areas determined on various substances by the usual technique, that is, involving a dead-space determination, are compared with those obtained by recalculation using equation (1) above in the following table:

	Area in	sq. m./gm.
Substance .	By dead-space determination	By recalculation
Carbon A	790	753
Carbon B	847	840
Carbon C	814	800
Carbon D	460	460
Carbon E	280	282
Chalk A	30	29
Chalk B	19	19
Paris White	2	2
Clay	10	10
Asbestos	18	14

It will be noted that the calculated areas are generally lower than the dead-space areas, that is, the slopes are too great: this is in accordance with the assumption made above. Our thanks are due to the directors of the Washington Chemical Company, Ltd., for permission to publish this note.

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 <sup>1</sup> Brunauer, Emmett and Teller, J. Amer. Chem. Soc., **60**, 309 (1938).
 <sup>2</sup> Emmett, P. H., "Symposium on New Methods of Determining Particle Size in Subsieve Range", Amer. Soc. Test. Mat., p. 95 (March 1941).

## An Optical-Acoustic Method of Gas Analysis

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